Applicant(s)/Patent Under Application/Control No. Reexamination 10/020,694 WANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Tae H Yoon 1714 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 524/86 09-2001 Ishizuka et al. US-2001/0023267 A1 Α US-В US-С US-D US-Ε US-F US-G US-Н US-Т US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν О Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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